Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
09/850,981	YOSHIHIRO ET AL.		
Examiner	Art Unit		
Vincent F. Boccio	2616		

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Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED						
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Huy Nguyen (2616) Consultati	10/2/08	r—		
Text Seoul Enclared	10/1/05	-		